

Enhancement Mode N-Channel Power MOSFET

PDFN3X3/NMOS/30V/ \pm 20V/1.5V/60A/3.7m Ω

Rev1.0





30V, 3.7mΩ, 60A, Single N-Channel

1.Features

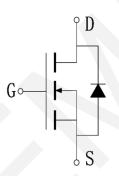
- ◆ 30V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±20V

- ♦ Power Switching Application
- Load Switching



Pin Description

V _{DS}	R _{DS(on)} Typ.	I _D Max.	
30V	3.7mΩ @ 10V	604	
	5.0mΩ @ 4.5V	60A	



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP3060KP3	WP3060KP3	PDFN3X3	5,000	50,000

4. Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	30	V
Gate to Source Voltage	V_{GSS}	±20	V
Drain Current (DC)	ID	60	А
Drain Current (Pulse), PW≤300μs	I _{DP}	240	А
Total Dissipation	P_{D}	65	W
Avalanche Energy, Single Pulsed	E _{AS}	144	mJ
Junction Temperature	Tj	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Junction to case	Rejc	2.3	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

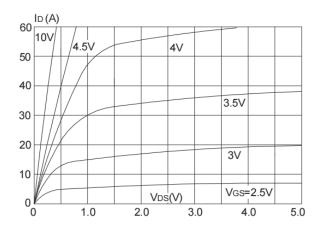
6.Electrical Characteristics at Ta=25°C (Note 3)

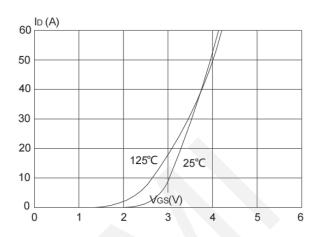
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A$, $V_{GS} = 0 V$	30	-	-	V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30V, V _{GS} = 0V	-		100	nA
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 20V$, $V_{DS} = 0V$	ı	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _{DS} =250µA	1.0	1.5	2.5	V
Static Drain to Source On-State	Б	I _D = 30A, V _{GS} = 10V	1	3.7	4.5	mΩ
Resistance	R _{DS(on)}	I _D = 20A, V _{GS} = 4.5V	-	5.0	7.5	mΩ
Forward Transconductance	G _{FS}	I _D = 20A, V _{DS} = 5V	20	-	-	S
Input Capacitance	Ciss	V _{GS} =0V,	-	2479	-	pF
Output Capacitance	Coss	V _{DS} =15V,	-	466	-	pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz	-	437	-	pF
Turn-ON Delay Time	t _{d(on)}		-	21	-	ns
Rise Time	tr	$V_{DS} = 15V, I_{D} = 30A,$	-	32	-	ns
Turn-OFF Delay Time	t _{d(off)}	$V_{GS} = 10V$, $R_G = 3\Omega$	-	60	-	ns
Fall Time	t _f		-	34	-	ns
	Qg	V _{DS} = 15V, V _{GS} = 10V, I _D = 30A	-	45	-	nC
Total Gate Charge	Qgs		-	3	-	nC
	Q_{gd}		-	15	-	nC
Diode Forward Voltage	V _{FSD}	I _S = 30A, V _{GS} = 0	0.5	0.85	1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

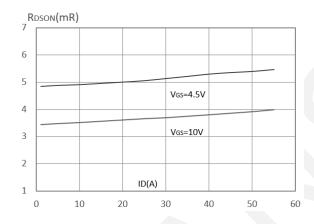


7. Typical electrical and thermal characteristics

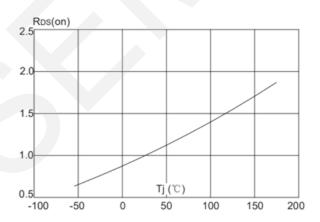




Output Characteristics

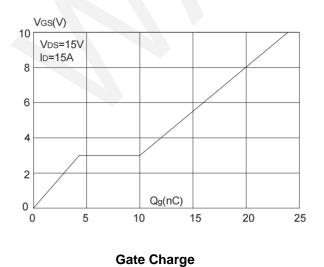


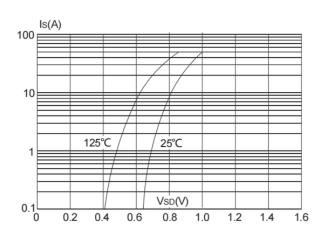
Transfer Characteristics



Rdson-Drain Current

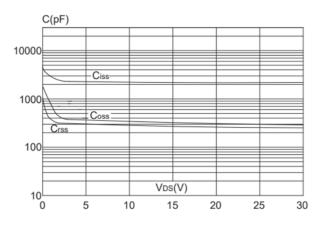
Rdson-Junction Temperature

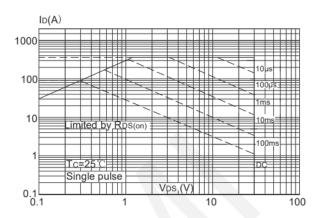




Source-Drain Diode Forward

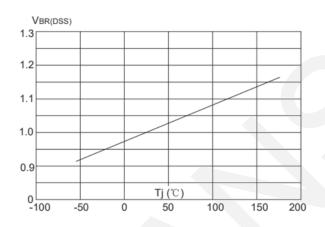


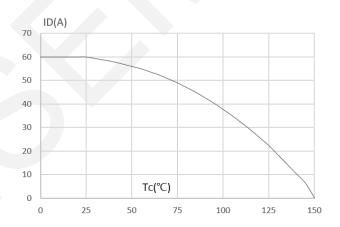




Capacitance vs Vds

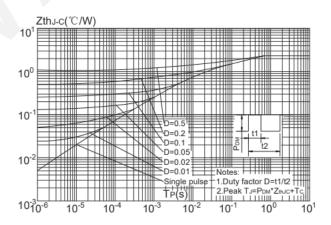
Safe Operation Area





BV_{DSS} vs Junction Temperature

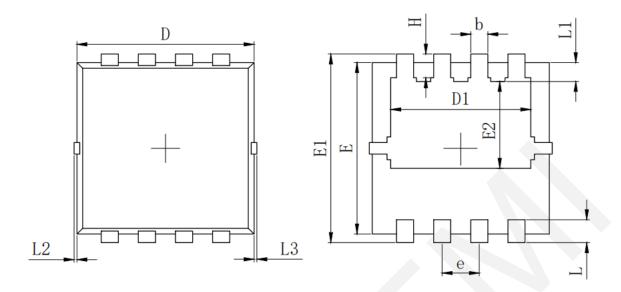
Maximum Continuous Drain Current vs. Case Temperature

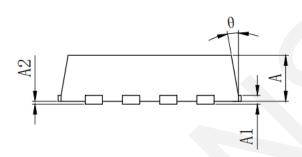


Normalized Maximum Transient Thermal Impedance



8.Package Dimensions





SYMBOL	MILLIMETER			
SIMBOL	MIN	Тур.	MAX	
A	0. 700	0.800	0.900	
A1		0. 152 REF.		
A2		0~0.05		
D	3.000	3. 100	3. 200	
D1	2. 300	2. 450	2.600	
E	2. 900	3.000	3. 100	
E1	3. 150	3. 300	3. 450	
E2	1. 320	1.520	1.720	
b	0. 200 0. 300 0. 4			
e	0.550	0.650	0.750	
L	0.300	0.400	0.500	
L1	0. 180	0.330	0.480	
L2	0~0. 100			
L3	0~0. 100			
H	0. 315	0.415	0.515	
θ	8°	10°	12°	



9. Important Notice

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